Spansion[®] Analog and Microcontroller Products



The following document contains information on Spansion analog and microcontroller products. Although the document is marked with the name "Fujitsu", the company that originally developed the specification, Spansion will continue to offer these products to new and existing customers.

Continuity of Specifications

There is no change to this document as a result of offering the device as a Spansion product. Any changes that have been made are the result of normal document improvements and are noted in the document revision summary, where supported. Future routine revisions will occur when appropriate, and changes will be noted in a revision summary.

Continuity of Ordering Part Numbers

Spansion continues to support existing part numbers beginning with "MB". To order these products, please use only the Ordering Part Numbers listed in this document.

For More Information

Please contact your local sales office for additional information about Spansion memory, analog, and microcontroller products and solutions.

ASSP BIPOLAR

VOLTAGE DETECTOR

MB3761

■ DESCRIPTION

Designed for voltage detector applications, the Fujitsu Microelectronics MB3761 is a dual comparator with a built-in high precision reference voltage generator. Outputs are open-collector outputs and enable use of the OR-connection between both channels. Both channels have hysteresis control outputs. Because of a wide power supply voltage range and a low power supply current, the MB3761 is suitable for power supply monitors and battery backup systems.

■ FEATURES

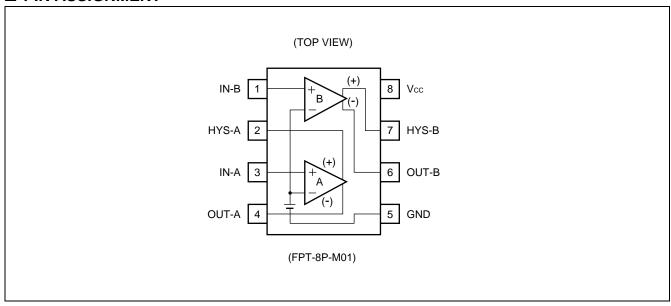
- Wide power supply voltage range: 2.5 V to 40 V
- Low power and small voltage dependency supply current: 250 μA Typ
- Built-in stable low voltage generator: 1.20 V Typ
- · Easy-to-add hysteresis characteristics.
- One type of package (SOP-8pin: 1 type)

■ APPLICATIONS

- Industrial Equipment
- Arcade Amusement etc.



■ PIN ASSIGNMENT



■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rat	Unit	
raiametei	Symbol	Min	Max	Onn
Power Supply Voltage	Vcc		41	V
Output Voltage	Vo		41	V
Output Current	lo		50	mA
Input Voltage	VIN	- 0.3	+ 6.5	V
Power Dissipation	PD	_	350 (T _A ≤ +70°C)	mW
Storage Temperature	Tstg	- 55	+ 125	°C

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol Min	lue	Unit	
Farameter		Min	Max	Onit
Power Supply Voltage	Vcc	2.5	40	V
Operating Ambient Temperature	TA	- 20	+ 75	°C
Output Current at pin 4	IO4	_	4.5	mA
Output Current at pin 6	IO6	_	3.0	mA

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is

operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

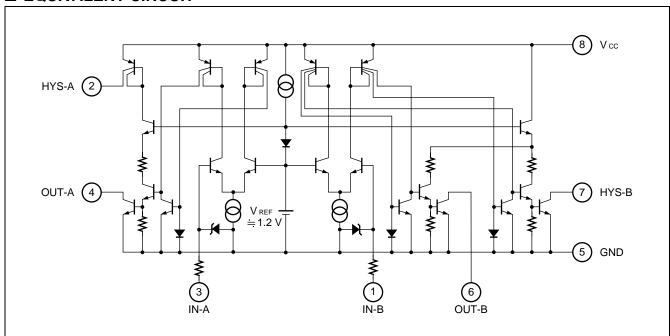
No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

■ ELECTRICAL CHARACTERISTICS

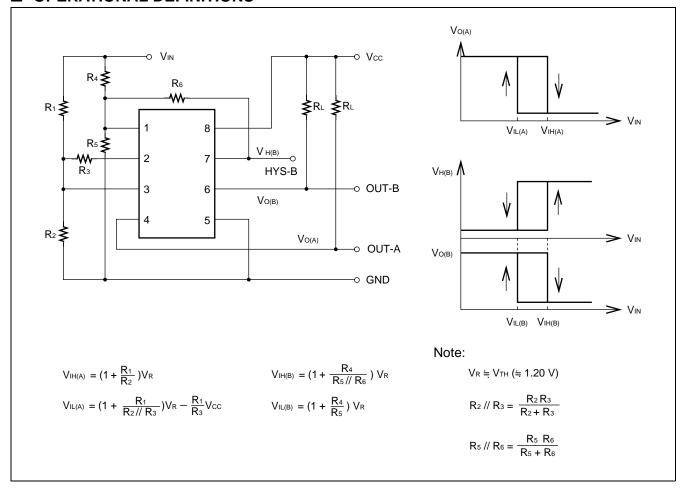
(TA=+25°C, VCC=5 V)

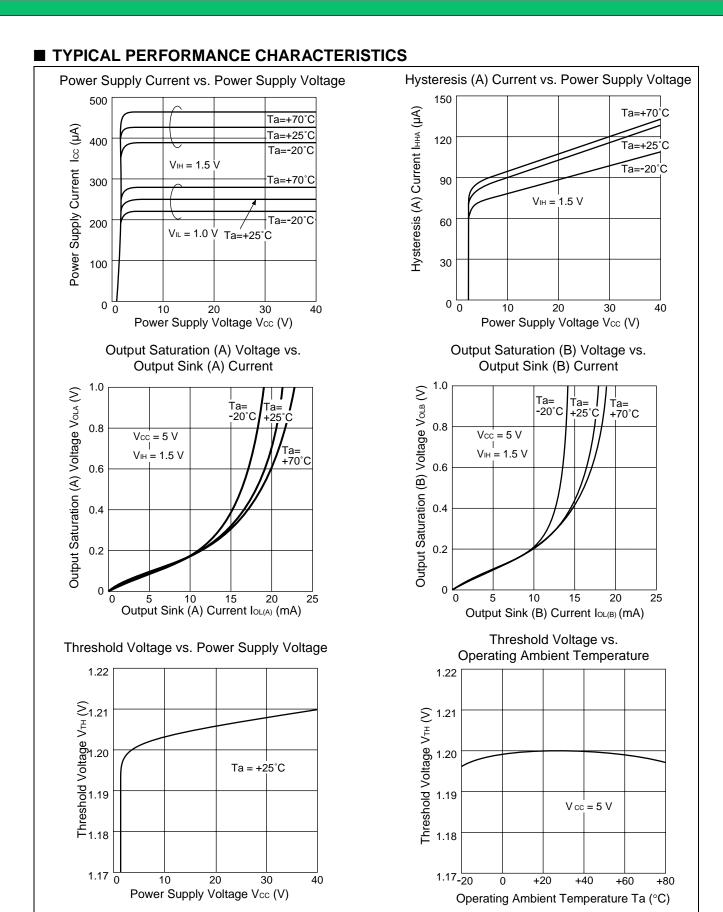
Parameter		l Conditions	Value			
	Symbol Conditions	Min	Тур	Max	Unit	
Power Supply Voltage	ICCL	VCC= 40 V, VIL= 1.0 V	-	250	400	μΑ
	Іссн	VCC= 40 V, VIH= 1.5 V	-	400	600	μΑ
Threshold Voltage	VTH	Io = 2 mA, Vo= 1 V	1.15	1.20	1.25	V
Deviation of Threshold Voltage	Δ VTH1	2.5 V ≤ VCC ≤ 5.5 V	-	3	12	mV
	Δ VTH2	4.5 V ≤ VCC ≤ 40 V	-	10	40	mV
Offset Voltage between Outputs	Voosa	IOA= 4.5 mA, VOA= 2 V, IHA= 20 μA, VHA= 3 V	-	2.0	-	mV
	Vossb	IOB= 3 mA, VOB= 2 V, IHB= 3 mA, VHB= 2 V	-	2.0	-	mV
Temperature Coefficient of Threshold Voltage	α	-20°C ≤ TA ≤ +70°C	-	±0.05	-	mV/°C
Difference Voltage on Threshold Voltage between Channel	Δ Vthab	-	-10	-	+10	mV
Innut Current	lıL	VIL= 1.0 V	-	5		nA
Input Current	Іін	VIH= 1.5 V	-	100	500	nA
Output Leakage Current	Іон	Vo= 40 V, VIL= 1.0 V	-	-	1	μΑ
Hysteresis Output Leakage Current	IHLA	VCC= 40 V, VHA= 0 V, VIL= 1.0 V	-	-	0.1	μΑ
	Іннв	VHB= 40 V, VIH= 1.5 V	-	-	1	μΑ
Output Sink Current	IOLA	Vo= 1.0 V, VIH= 1.5 V	6	12	-	mA
Output Sink Current	IOLB	Vo= 1.0 V, VIH= 1.5 V	4	10	-	mA
Hysteresis Current	Інна	VH= 0 V, VIH= 1.5 V	40	80	-	μΑ
Hysteresis Current	IHLB	VH= 1.0 V,VIL = 1.0 V	4	10	-	mA
Output Saturation Voltage	Vola	IO= 4.5 mA, VIH= 1.5 V	-	120	400	mV
	Volb	IO= 3.0 mA, VIH= 1.5 V	-	120	400	mV
Hysteresis Saturation	Vнна	IH= 20 μA, VIH= 1.5 V	-	50	200	mV
	VHLB	IH= 3.0 mA, VIL= 1.0 V	-	120	400	mV
Output Dolay Time	tPHL	RL= 5 kΩ	-	2	-	μS
Output Delay Time	tPLH	RL= 5 kΩ	-	3	-	μS

■ EQUIVALENT CIRCUIT



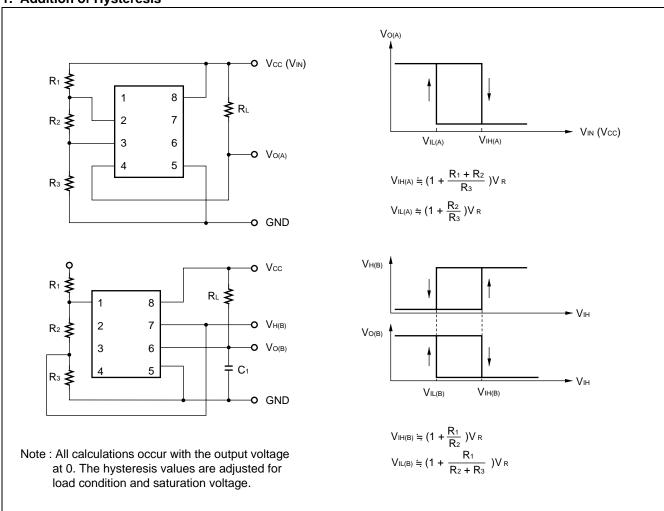
■ OPERATIONAL DEFINITIONS



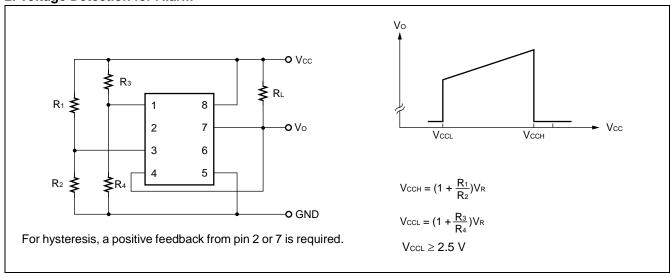


■ APPLICATION EXAMPLES

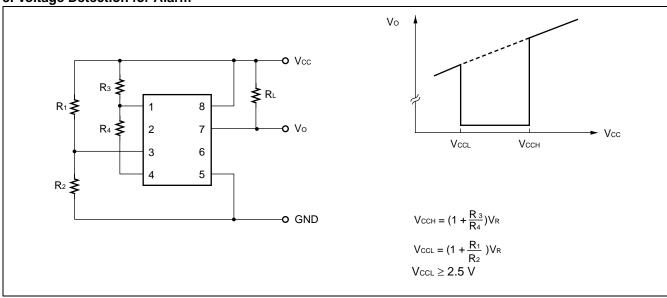
1. Addition of Hysteresis



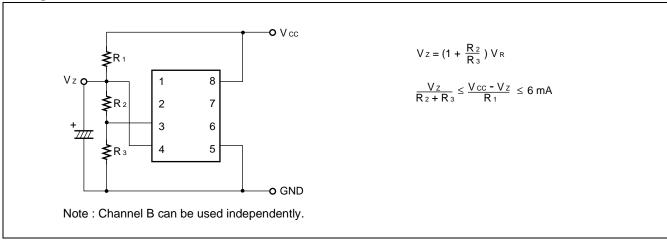
2. Voltage Detection for Alarm



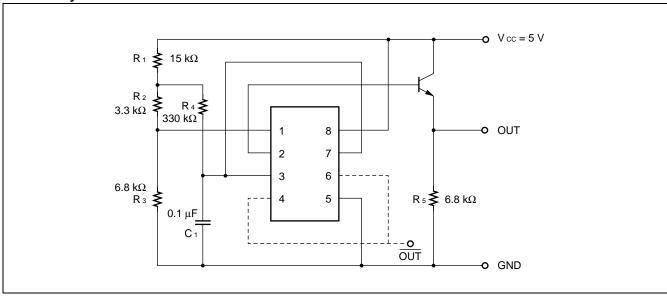
3. Voltage Detection for Alarm



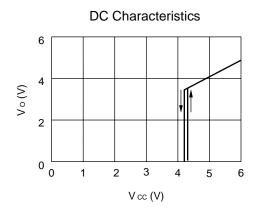
4. Programmable Zener



5. Recovery Reset Circuit



■ TYPICAL CHARACTERISTICS



 Voltage Threshold Levels (VCCL and VCCH) and Hysteresis Width can be changed by the resistors (R1 through R4).

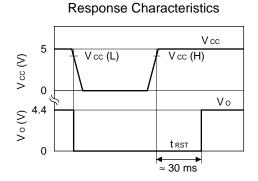
$$VCCL = \frac{R1 + R2 + R3}{R3} VTH$$

$$VCCH = VCCL + \frac{R1 (R2 + R3)}{R3 R4} VTH$$

 Power-On Reset Time is provided by the following approximate equation:

$$tRST = -C1 R4 \cdot ln \left\{ 1 - \frac{VTH}{VCC} \left(1 + \frac{R1}{R2 + R3} \right) \right\}$$

- The recommended value of hFE of the external transistor is from 50 to 200.
- In the case of an instant power fail, the remaining charge in C1 effects trst.
- If necessary, the reversed output is provided on HYS terminal



■ NOTES ON USE

- Take account of common impedance when designing the earth line on a printed wiring board.
- Take measures against static electricity.
 - For semiconductors, use antistatic or conductive containers.
 - When storing or carrying a printed circuit board after chip mounting, put it in a conductive bag or container.
 - The work table, tools and measuring instruments must be grounded.
 - The worker must put on a grounding device containing 250 k Ω to 1 M Ω resistors in series.
- · Do not apply a negative voltage
 - Applying a negative voltage of -0.3 V or less to an LSI may generate a parasitic transistor, resulting in malfunction.

■ ORDERING INFORMATION

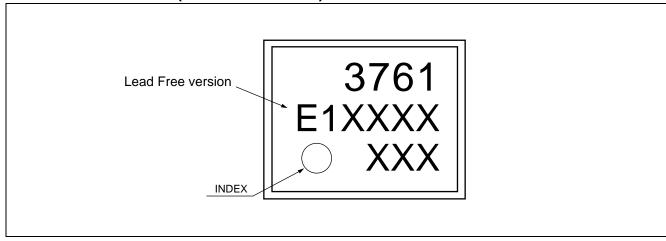
Part number	Package	Remarks
MB3761PF-□□□	8-pin plastic SOP (FPT-8P-M01)	Conventional version
MB3761PF-□□□E1	8-pin plastic SOP (FPT-8P-M01)	Lead Free version

■ RoHS Compliance Information of Lead (Pb) Free version

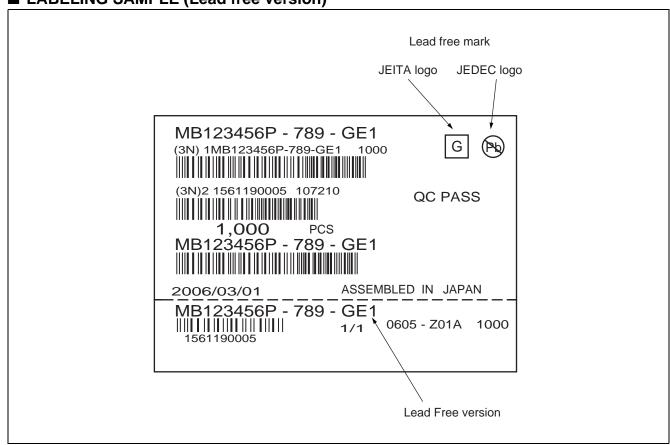
The LSI products of Fujitsu Microelectronics with "E1" are compliant with RoHS Directive , and has observed the standard of lead, cadmium, mercury, Hexavalent chromium, polybrominated biphenyls (PBB) , and polybrominated diphenyl ethers (PBDE) .

The product that conforms to this standard is added "E1" at the end of the part number.

■ MARKING FORMAT (Lead Free version)



■ LABELING SAMPLE (Lead free version)

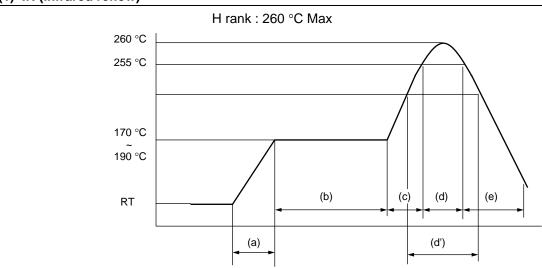


■ MB3761PF-□□□□E1 RECOMMENDED CONDITIONS OF MOISTURE SENSITIVITY LEVEL

Item	Condition		
Mounting Method	IR (infrared reflow), Manual soldering (partial heating method)		
Mounting times	2 times		
	Before opening	Please use it within two years after Manufacture.	
Storage period	From opening to the 2nd reflow	Less than 8 days	
	When the storage period after opening was exceeded	Please processes within 8 days after baking (125 °C, 24H)	
Storage conditions	5 °C to 30 °C, 70%RH or less (the lowest possible humidity)		

[Temperature Profile for FJ Standard IR Reflow]

(1) IR (infrared reflow)



(a) Temperature Increase gradient $\,$: Average 1 $\,$ °C/s to 4 $\,$ °C/s

(b) Preliminary heating : Temperature 170 °C to 190 °C, 60s to 180s

(c) Temperature Increase gradient $\,$: Average 1 $^{\circ}\text{C/s}$ to 4 $^{\circ}\text{C/s}$

(d) Actual heating : Temperature 260 °C Max; 255 °C or more, 10s or less

(d') : Temperature 230 °C or more, 40s or less

or

Temperature 225 °C or more, 60s or less

or

Temperature 220 °C or more, 80s or less

(e) Cooling : Natural cooling or forced cooling

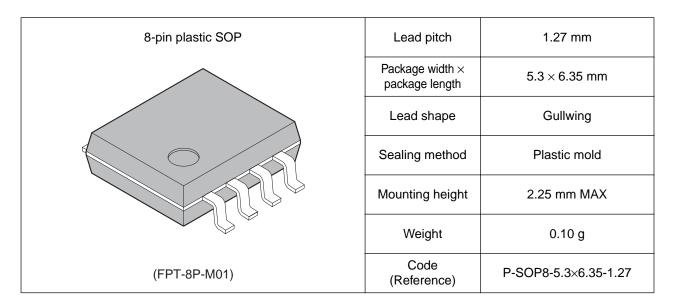
Note: Temperature: the top of the package body

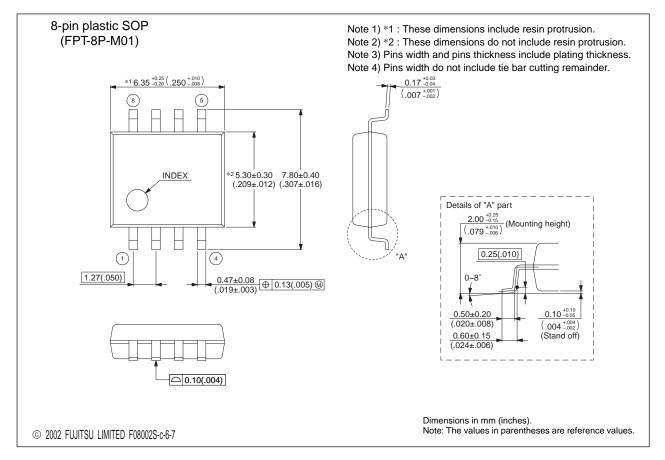
(2) Manual soldering (partial heating method)

Conditions: Temperature 400 °C Max

Times : 5 s max/pin

■ PACKAGE DIMENSION





(MEMO)		

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